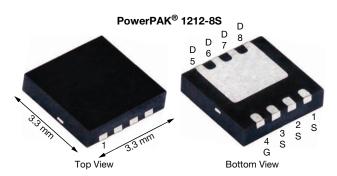




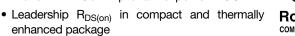
P-Channel 20 V (D-S) MOSFET



PRODUCT SUMMARY				
V _{DS} (V)	-20			
$R_{DS(on)}$ max. (Ω) at $V_{GS} = -4.5 \text{ V}$	0.0027			
$R_{DS(on)}$ max. (Ω) at $V_{GS} = -2.5 \text{ V}$	0.0036			
$R_{DS(on)}$ max. (Ω) at $V_{GS} = -1.8 \text{ V}$	0.0070			
Q _g typ. (nC)	72.2			
I _D (A)	-127.5			
Configuration	Single			

FEATURES

TrenchFET® Gen III p-channel power MOSFET



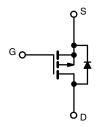
ROHS COMPLIANT HALOGEN FREE

• 100 % R_a and UIS tested

 Material categorization: for definitions of compliance please see www.vishav.com/doc?99912

APPLICATIONS

- · Battery management
- · Load switch



P-Channel MOSFET

ORDERING INFORMATION	
Package	PowerPAK 1212-8S
Lead (Pb)-free and halogen-free	SiSS63DN-T1-GE3

PARAMETER		SYMBOL	LIMIT	UNIT
Drain-source voltage		V _{DS}	-20	V
Gate-source voltage		V _{GS}	± 12	v
Continuous drain current (T _J = 150 °C)	T _C = 25 °C		-127.5	
	T _C = 70 °C	T , [-102	
	T _A = 25 °C	† ' _D †	-35.1 ^{b, c}	
	T _A = 70 °C	1	-28.1	
Pulsed drain current (t = 100 μs)		I _{DM}	-200	A
Continuous source-drain diode current	T _C = 25 °C		-54.8	
	T _A = 25 °C	ls l	-4.2 ^{b, c}	
Single pulse avalanche current	L = 0.1 mH	I _{AS}	-25	
Single pulse avalanche energy	L = U. I IIIIA	E _{AS}	31.2	mJ
Maximum power dissipation	T _C = 25 °C		65.8	
	T _C = 70 °C	T , [42.1	w
	T _A = 25 °C	P _D	5 b, c	VV
	T _A = 70 °C	1	3.2 ^{b, c}	
Operating junction and storage temperature range		T _J , T _{stg}	-55 to +150	°C
Soldering recommendations (peak temperature) c			260	

THERMAL RESISTANCE RATINGS							
PARAMETER		SYMBOL	TYPICAL	MAXIMUM	UNIT		
Maximum junction-to-ambient ^b	t ≤ 10 s	R _{thJA}	20	25	°C/W		
Maximum junction-to-case (drain)	Steady state	R _{thJC}	1.5	1.9	C/VV		

Notes

- a. $T_C = 25 \,^{\circ}C$
- b. Surface mounted on 1" x 1" FR4 board
- c. t = 10 s
- d. See solder profile (www.vishay.com/doc?73257). The PowerPAK 1212-8S is a leadless package. The end of the lead terminal is exposed copper (not plated) as a result of the singulation process in manufacturing. A solder fillet at the exposed copper tip cannot be guaranteed and is not required to ensure adequate bottom side solder interconnection
- e. Rework conditions: manual soldering with a soldering iron is not recommended for leadless components
- f. Maximum under steady state conditions is 65 °C/W



Vishay Siliconix

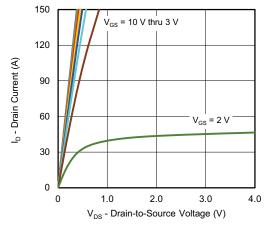
PARAMETER	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT	
Static					L		
Drain-source breakdown voltage	V_{DS}	$V_{GS} = 0 \text{ V}, I_{D} = -250 \mu\text{A}$	-20	-	-	V	
V _{DS} temperature coefficient	$\Delta V_{DS}/T_{J}$	I _D = -10 mA	-	-15	-		
V _{GS(th)} temperature coefficient	$\Delta V_{GS(th)}/T_J$	I _D = -250 μA	-	4	-	mV/°C	
Gate-source threshold voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_{D} = -250 \mu A$	-0.5	-	-1.5	V	
Gate-source leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 12 \text{ V}$	-	-	100	nA	
Zero gate voltage drain current		V _{DS} = -20 V, V _{GS} = 0 V	-	-	-1	μА	
	I _{DSS}	V _{DS} = -20 V, V _{GS} = 0 V, T _J = 70 °C	-	-	-15		
On-state drain current ^a	I _{D(on)}	$V_{DS} \ge -10 \text{ V}, V_{GS} = -10 \text{ V}$	-20	-	-	Α	
Drain-source on-state resistance ^a	R _{DS(on)}	$V_{GS} = -10 \text{ V}, I_D = -15 \text{ A}$	-	0.0022	0.0027	<u> </u>	
		$V_{GS} = -4.5 \text{ V}, I_D = -10 \text{ A}$	-	0.0030	0.0036	Ω	
	, ,	$V_{GS} = -2.5 \text{ V}, I_D = -5 \text{ A}$	-	0.0053	0.0070	1	
Forward transconductance ^a	9 _{fs}	$V_{DS} = -10 \text{ V}, I_D = -15 \text{ A}$	-	75	-	S	
Dynamic ^b						•	
Input capacitance	C _{iss}	V _{DS} = -10 V, V _{GS} = 0 V, f = 1 MHz	-	7080	-	pF	
Output capacitance	Coss		-	1000	-		
Reverse transfer capacitance	C _{rss}		-	1110	-		
Total note about	0	$V_{DS} = -10 \text{ V}, V_{GS} = -8 \text{ V}, I_D = -35.1 \text{ A}$	-	157.2	236	nC	
Total gate charge	Q_g	V _{DS} = -10 V, V _{GS} = -4.5 V, I _D = -35.1 A	-	72.2	110		
Gate-source charge	Q_{gs}		-	17.7	-		
Gate-drain charge	Q _{gd}		-	22	-		
Gate resistance	R_g	f = 1 MHz	0.3	1.5	3	Ω	
Turn-on delay time	t _{d(on)}		-	20	40		
Rise time	t _r	$V_{DD} = -10 \text{ V}, R_L = 0.36 \Omega, I_D \cong -28.1 \text{ A},$	-	28	56		
Turn-off delay time	t _{d(off)}	$V_{GEN} = -10 \text{ V}, R_g = 1 \Omega$	-	80	160		
Fall time	t _f		-	25	50		
Turn-on delay time	t _{d(on)}		-	40	80	ns	
Rise time	t _r	V_{DD} = -10 V, R_L = 0.36 Ω , I_D \cong -28.1 A,	-	60	120		
Turn-off delay time	t _{d(off)}	$V_{GEN} = -4.5 \text{ V}, R_g = 1 \Omega$	-	100	200		
Fall time	t _f		-	70	140		
Drain-Source Body Diode Characteristi	cs						
Continuous source-drain diode current	I _S	T _C = 25 °C	-	-	-54.8		
Pulse diode forward current	I _{SM}		-	-	-200	A	
Body diode voltage	V_{SD}	I _S = -5 A, V _{GS} = 0 V	-	-0.66	-1.2	V	
Body diode reverse recovery time	t _{rr}		-	20	40	ns	
Body diode reverse recovery charge	Q_{rr}	I _F = -28.1 A, di/dt = 100 A/μs,	-	9.5	19	nC	
Reverse recovery fall time	ta	T _J = 25 °C	-	11.5	-		
Reverse recovery rise time	t _b		-	8.5	_	ns	

Notes

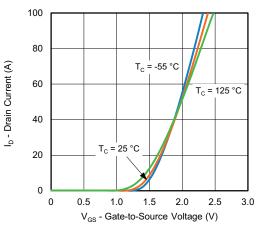
- a. Pulse test; pulse width $\leq 300~\mu s,~duty~cycle \leq 2~\%$
- b. Guaranteed by design, not subject to production testing

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

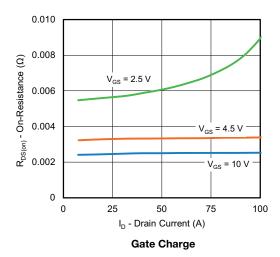


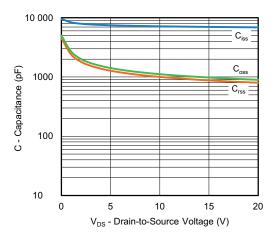


Output Characteristics

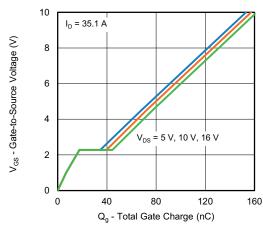


On-Resistance vs. Drain Current and Gate Voltage

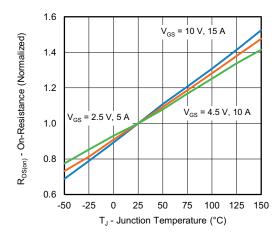




Transfer Characteristics

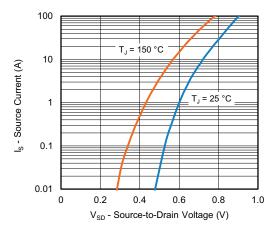


Capacitance

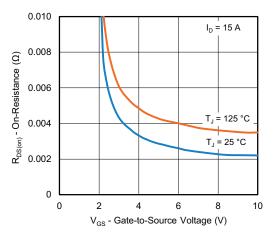


On-Resistance vs. Junction Temperature

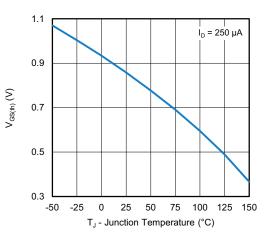




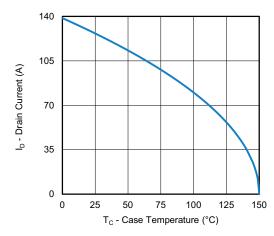
Source-Drain Diode Forward Voltage



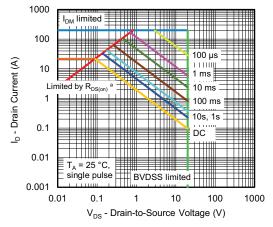
On-Resistance vs. Gate-to-Source Voltage



Threshold Voltage



Single Pulse Power, Junction-to-Ambient



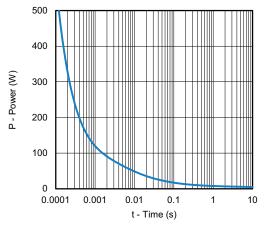
Safe Operating Area, Junction-to-Ambient

Note

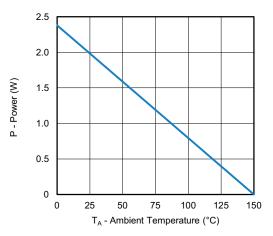
a. V_{GS} > minimum V_{GS} at which $R_{DS(on)}$ is specified

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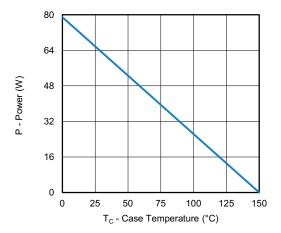




Current Derating a



Single Pulse Power, Junction-to-Ambient

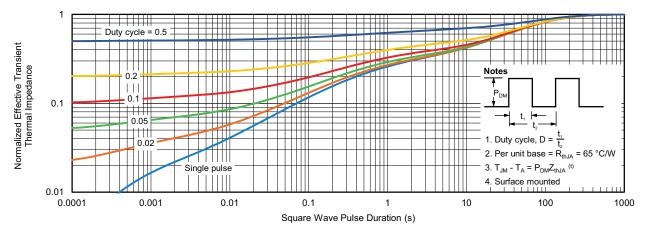


Power, Junction-to-Case

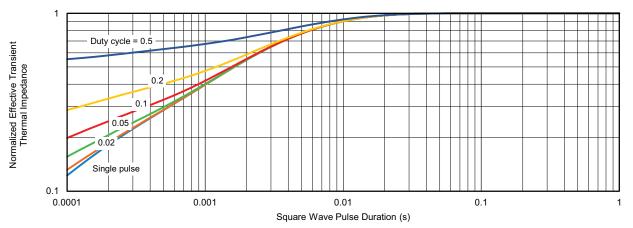
Note

a. The power dissipation P_D is based on T_J max. = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit





Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Case

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